

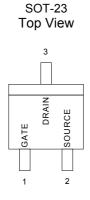
GENERAL DESCRIPTION

This N-Channel enhancement mode field effect transistor is produced using high cell density, DMOS technology. These products have been designed to minimize on-state resistance while provide rugged, reliable, and fast switching performance. It can be used in most applications requiring up to 115mA DC and can deliver pulsed currents up to 800mA. This product is particularly suited for low voltage, low current applications such as small servo motor control, power MOSFET gate drivers, and other switching applications.

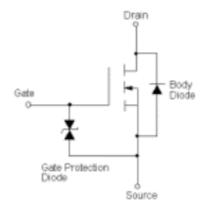
FEATURES

- ◆ High Density Cell Design for Low R_{DS(ON)}
- ◆ Voltage Controlled Small Signal Switch
- ◆ Rugged and Reliable
- High Saturation Current Capability
- ♦ Built-in G-S Protection Diode

PIN CONFIGURATION



SYMBOL



N-Channel MOSFET

ORDERING INFORMATION

Part Number	Package
CMT2N7002AG	SOT-23

*Note: G : Suffix for Pb Free Product



ABSOLUTE MAXIMUM RATINGS

Rating		Value	Unit
Drain Source Voltage	V_{DSS}	60	V
Drain-Gate Voltage (R_{GS} = 1.0MΩ)	V_{DGR}	60	V
Drain to Current — Continuous		±115	mA
Pulsed	I _{DM}	±800	
Gate-to-Source Voltage	V_{GS}	±20	V
Total Power Dissipation		225	mW
Derate above 25℃		1.8	mW/°C
Single Pulse Drain-to-Source Avalanche Energy $-T_J$ = 25 $^{\circ}$ C		2.5	mJ
$(V_{DD} = 50V, V_{GS} = 10V, I_{AS} = 0.5A, L = 20mH, R_G = 25\Omega)$			
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to 150	$^{\circ}\!\mathbb{C}$
Thermal Resistance — Junction to Ambient	θ_{JA}	417	°C/W
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	300	$^{\circ}\mathbb{C}$

ELECTRICAL CHARACTERISTICS (Unless otherwise specified, T_J = 25°C.)

			CMT2N7002AG			
Cha	racteristic	Symbol	Min	Тур	Max	Units
Drain-Source Breakdown Voltage		V _{(BR)DSS}	60			V
$(V_{GS} = 0 \text{ V}, I_D = 10 \ \mu \text{ A})$						
Drain-Source Leakage Current		I _{DSS}				
(V _{DS} = 60 V, V _{GS} = 0 V)					1.0	μ A
$(V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 1$	25℃)				0.5	mA
Gate-Source Leakage Current-Fo	orward (V _{gsf} = 20 V)	I_{GSS}			10	uA
Gate-Source Leakage Current-Reverse (V _{gsf} = -20 V)		I _{GSS}			-10	uA
Gate Threshold Voltage *		V _{GS(th)}	1.0		2.5	V
$(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$						
On-State Drain Current (V _{DS} ≥ 2.0 V _{DS(on)} , V _{GS} = 10V)		$I_{d(on)}$	500			mA
Static Drain-Source On-Resistan	ce *	R _{DS(on)}				Ω
$(V_{GS} = 10 \text{ V}, I_D = 0.5\text{A})$					7.5	
$(V_{GS} = 10 \text{ V}, I_D = 0.5\text{A}, T_C = 125^{\circ}\text{C})$					13.5	
$(V_{GS} = 5.0 \text{ V}, I_D = 50\text{mA})$					7.5	
$(V_{GS} = 5.0 \text{ V}, I_D = 50 \text{mA}, T_C = 125^{\circ}\text{C})$					13.5	
Drain-Source On-Voltage *		$V_{DS(on)}$				V
$(V_{GS} = 10 \text{ V}, I_D = 0.5\text{A})$					3.75	
$(V_{GS} = 5.0 \text{ V}, I_D = 50\text{mA})$					0.375	
Forward Transconductance ($V_{DS} \ge 2.0 V_{DS(on)}$, $I_D = 200 mA$) *		9 FS	80			mmhos
Input Capacitance	(V = 25 V, V = 0 V	C _{iss}			50	pF
Output Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz)	Coss			25	pF
Reverse Transfer Capacitance	1 – 1.0 ((112)	C _{rss}			5.0	pF
Turn-On Delay Time	(V _{DD} = 25 V, I _D = 500 mA,	t _{d(on)}			20	ns
Turn-Off Delay Time	$V_{gen} = 10 \text{ V}, R_G = 25\Omega, R_L = 50\Omega) *$	t _{d(off)}			40	ns
Diode Forward On-Voltage (IS = 115 mA, VGS = 0V)		V _{SD}			-1.5	V
Source Current Continuous (Body Diode)		IS			-115	mA
Source Current Pulsed		I _{SM}			-800	mA

^{*} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%



TYPICAL ELECTRICAL CHARACTERISTICS

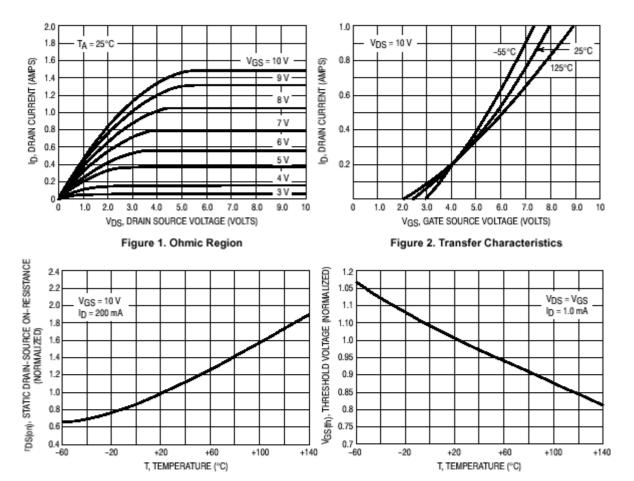


Figure 3. Temperature versus Static Drain-Source On-Resistance

Figure 4. Temperature versus Gate Threshold Voltage

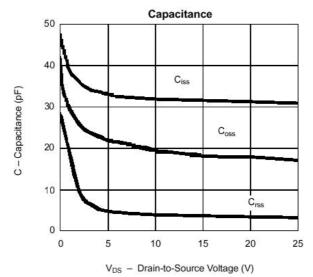
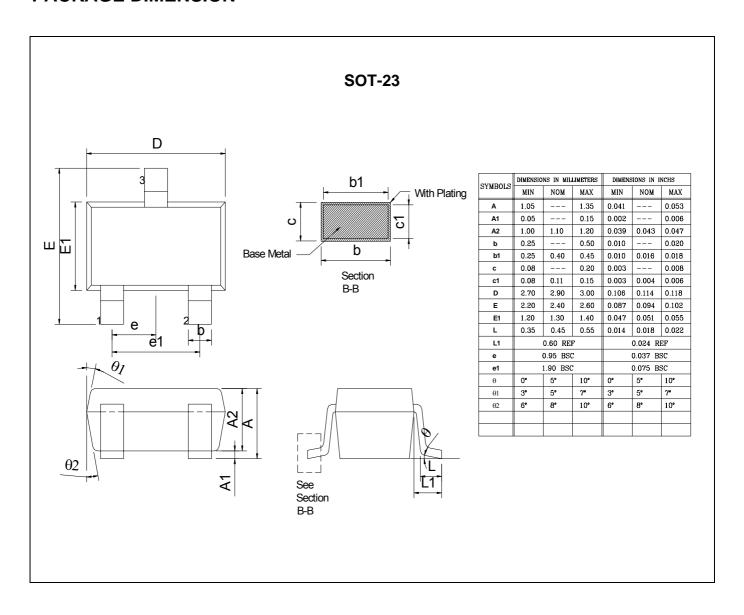


Figure 5. Capacitance



PACKAGE DIMENSION





IMPORTANT NOTICE

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